

Research on fault prediction method of elevator door system based on transfer learning

Pan J, Shao C, Dai Y, Wei Y, Chen W, Lin Z.
Sensors (Basel)
2024; 24(7):e2135

ARTICLE IDENTIFIERS

DOI: 10.3390/s24072135
PMID: unavailable
PMCID: not available

JOURNAL IDENTIFIERS

LCCN: 2002242115
pISSN: not available
eISSN: 1424-8220
OCLC ID: 47250782
CONS ID: not available
US National Library of Medicine ID: 101204366

This article was identified from a query of the SafetyLit database.